

Notice of References Cited

Application/Control No.

10/564,658

Applicant(s)/Patent Under
Reexamination
BECHTEL ET AL.

Examiner

Matthew W. Such

Art Unit

2891

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,133,581	10-2000	Terao et al.	257/40
	B	US-			
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	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	EP 888035 A1	12-1998	European Patent	HOSOKAWA et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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